

MC74HCT4066A

Quad Analog Switch/ Multiplexer/Demultiplexer with LSTTL Compatible Inputs

High-Performance Silicon-Gate CMOS

The MC74HCT4066A utilizes silicon-gate CMOS technology to achieve fast propagation delays, low ON resistances, and low OFF-channel leakage current. This bilateral switch/multiplexer/demultiplexer controls analog and digital voltages that may vary across the full power-supply range (from V_{CC} to GND).

The HCT4066A is identical in pinout to the metal-gate CMOS MC14016 and MC14066. Each device has four independent switches. The device has been designed so the ON resistances (R_{ON}) are more linear over input voltage than R_{ON} of metal-gate CMOS analog switches.

The ON/OFF control inputs are compatible with standard CMOS and LSTTL outputs. For analog switches with voltage-level translators, see the HC4316A.

Features

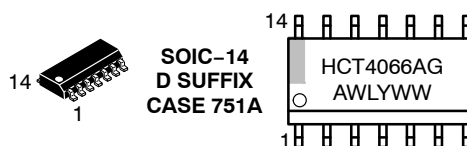
- Fast Switching and Propagation Speeds
- High ON/OFF Output Voltage Ratio
- Low Crosstalk Between Switches
- Diode Protection on All Inputs/Outputs
- Wide Power-Supply Voltage Range ($V_{CC} - GND$) = 4.5 to 5.5 V
- Analog Input Voltage Range ($V_{CC} - GND$) = 0 to 5.5 V
- Improved Linearity and Lower ON Resistance over Input Voltage than the MC14016 or MC14066
- Low Noise
- Chip Complexity: 44 FETs or 11 Equivalent Gates
- These are Pb-Free Devices



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MARKING DIAGRAMS



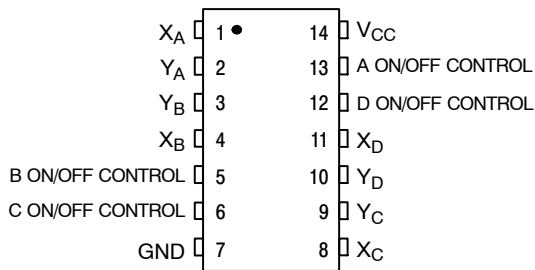
A = Assembly Location
L, WL = Wafer Lot
Y, YY = Year
W, WW = Work Week
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

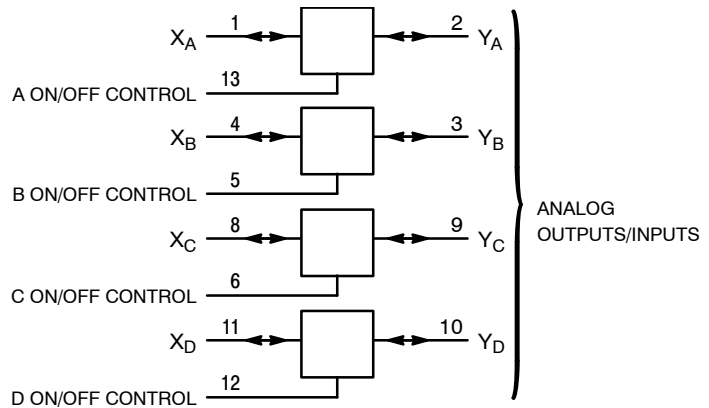
See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

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FUNCTION TABLE

On/Off Control Input	State of Analog Switch
L	Off
H	On



ANALOG INPUTS/OUTPUTS = X_A , X_B , X_C , X_D

PIN 14 = V_{CC}

PIN 7 = GND

ORDERING INFORMATION

Device	Package	Shipping [†]
MC74HCT4066ADG	SOIC-14 (Pb-Free)	55 Units / Rail
MC74HCT4066ADR2G	SOIC-14 (Pb-Free)	2500 / Tape & Reel
MC74HCT4066ADTR2G	TSSOP-14*	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*This package is inherently Pb-Free.

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MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Positive DC Supply Voltage (Referenced to GND)	-0.5 to +14.0	V
V_{IS}	Analog Input Voltage (Referenced to GND)	-0.5 to $V_{CC} + 0.5$	V
V_{in}	Digital Input Voltage (Referenced to GND)	-0.5 to $V_{CC} + 0.5$	V
I	DC Current Into or Out of Any Pin	± 25	mA
P_D	Power Dissipation in Still Air, SOIC Package† TSSOP Package†	500 450	mW
T_{stg}	Storage Temperature	-65 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

†Derating – SOIC Package: - 7 mW/°C from 65°C to 125°C
TSSOP Package: - 6.1 mW/°C from 65°C to 125°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range $GND \leq (V_{in} \text{ or } V_{out}) \leq V_{CC}$.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). Unused outputs must be left open. I/O pins must be connected to a properly terminated line or bus.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V_{CC}	Positive DC Supply Voltage (Referenced to GND)	4.5	5.5	V
V_{IS}	Analog Input Voltage (Referenced to GND)	GND	V_{CC}	V
V_{in}	Digital Input Voltage (Referenced to GND)	GND	V_{CC}	V
V_{IO}^*	Static or Dynamic Voltage Across Switch	-	1.2	V
T_A	Operating Temperature, All Package Types	-55	+125	°C
t_r, t_f	Input Rise and Fall Time, ON/OFF Control Inputs (Figure 10) $V_{CC} = 4.5 \text{ V}$	0	500	ns

*For voltage drops across the switch greater than 1.2 V (switch on), excessive V_{CC} current may be drawn; i.e., the current out of the switch may contain both V_{CC} and switch input components. The reliability of the device will be unaffected unless the Maximum Ratings are exceeded.

DC ELECTRICAL CHARACTERISTIC Digital Section (Voltages Referenced to GND)

Symbol	Parameter	Test Conditions	V_{CC} V	Guaranteed Limit			Unit
				- 55 to 25°C	≤ 85°C	≤ 125°C	
V_{IH}	Minimum High-Level Voltage ON/OFF Control Inputs	$R_{on} = \text{Per Spec}$	4.5 to 5.5	2.0	2.0	2.0	V
V_{IL}	Maximum Low-Level Voltage ON/OFF Control Inputs	$R_{on} = \text{Per Spec}$	4.5 to 5.5	0.8	0.8	0.8	V
I_{in}	Maximum Input Leakage Current ON/OFF Control Inputs	$V_{in} = V_{CC} \text{ or } GND$	5.5	± 0.1	± 1.0	± 1.0	μA
I_{CC}	Maximum Quiescent Supply Current (per Package)	$V_{in} = V_{CC} \text{ or } GND$ $V_{IO} = 0 \text{ V}$	5.5	2	20	40	μA
ΔI_{CC}	Additional Quiescent Supply Current (per Input)	$V_{in} = V_{CC} - 2.1 \text{ V}$ Other control inputs at V_{CC} or GND	4.5 to 5.5	360	450	490	μA

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DC ELECTRICAL CHARACTERISTICS Analog Section (Voltages Referenced to GND)

Symbol	Parameter	Test Conditions	V _{CC} V	Guaranteed Limit			Unit
				– 55 to 25°C	≤ 85°C	≤ 125°C	
R _{on}	Maximum “ON” Resistance	V _{in} = V _{IH} V _{IS} = V _{CC} to GND I _S ≤ 2.0 mA (Figures 3, 4)	4.5	120	160	200	Ω
		V _{in} = V _{IH} V _{IS} = V _{CC} or GND (Endpoints) I _S ≤ 2.0 mA (Figures 3, 4)	4.5	70	85	120	
ΔR _{on}	Maximum Difference in “ON” Resistance Between Any Two Channels in the Same Package	V _{in} = V _{IH} V _{IS} = 1/2 (V _{CC} – GND) I _S ≤ 2.0 mA	4.5	20	25	30	Ω
I _{off}	Maximum Off-Channel Leakage Current, Any One Channel	V _{in} = V _{IL} V _{IO} = V _{CC} or GND Switch Off (Figure 5)	5.5	0.1	0.5	1.0	μA
I _{on}	Maximum On-Channel Leakage Current, Any One Channel	V _{in} = V _{IH} V _{IS} = V _{CC} or GND (Figure 6)	5.5	0.1	0.5	1.0	μA

AC ELECTRICAL CHARACTERISTICS (C_L = 50 pF, ON/OFF Control Inputs: t_r = t_f = 6 ns)

Symbol	Parameter	V _{CC} V	Guaranteed Limit			Unit
			– 55 to 25°C	≤ 85°C	≤ 125°C	
t _{PLH} , t _{PHL}	Maximum Propagation Delay, Analog Input to Analog Output (Figures 10 and 11)	4.5	10	13	15	ns
t _{PLZ} , t _{PHZ}	Maximum Propagation Delay, ON/OFF Control to Analog Output (Figures 12 and 13)	4.5	30	38	45	ns
t _{PZL} , t _{PZH}	Maximum Propagation Delay, ON/OFF Control to Analog Output (Figures 12 and 13)	4.5	25	32	37	ns
C	Maximum Capacitance ON/OFF Control Input	–	10	10	10	pF
	Control Input = GND	–	35	35	35	
	Analog I/O Feedthrough	–	1.0	1.0	1.0	

C _{PD}	Power Dissipation Capacitance (Per Switch) (Figure 15)*	Typical @ 25°C, V _{CC} = 5.0 V	pF
		15	

*Used to determine the no-load dynamic power consumption: P_D = C_{PD} V_{CC}²f + I_{CC} V_{CC}.

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ADDITIONAL APPLICATION CHARACTERISTICS (Voltages Referenced to GND Unless Noted)

Symbol	Parameter	Test Conditions	V _{CC} V	Limit* 25°C 54/74HCT	Unit
BW	Maximum On-Channel Bandwidth or Minimum Frequency Response (Figure 7)	f _{in} = 1 MHz Sine Wave Adjust f _{in} Voltage to Obtain 0 dBm at V _{OS} Increase f _{in} Frequency Until dB Meter Reads – 3 dB R _L = 50 Ω, C _L = 10 pF	4.5	150	MHz
–	Off-Channel Feedthrough Isolation (Figure 8)	f _{in} ≡ Sine Wave Adjust f _{in} Voltage to Obtain 0 dBm at V _{IS} f _{in} = 10 kHz, R _L = 600 Ω, C _L = 50 pF	4.5	–50	dB
		f _{in} = 1.0 MHz, R _L = 50 Ω, C _L = 10 pF	4.5	–40	
–	Feedthrough Noise, Control to Switch (Figure 9)	V _{in} ≤ 1 MHz Square Wave (t _r = t _f = 6 ns) Adjust R _L at Setup so that I _S = 0 A R _L = 600 Ω, C _L = 50 pF	4.5	60	mV _{PP}
		R _L = 10 kΩ, C _L = 10 pF	4.5	30	
–	Crosstalk Between Any Two Switches (Figure 14)	f _{in} ≡ Sine Wave Adjust f _{in} Voltage to Obtain 0 dBm at V _{IS} f _{in} = 10 kHz, R _L = 600 Ω, C _L = 50 pF	4.5	–70	dB
		f _{in} = 1.0 MHz, R _L = 50 Ω, C _L = 10 pF	4.5	–80	
THD	Total Harmonic Distortion (Figure 16)	f _{in} = 1 kHz, R _L = 10 kΩ, C _L = 50 pF THD = THD _{Measured} – THD _{Source} V _{IS} = 4.0 V _{PP} sine wave	4.5	0.10	%

*Guaranteed limits not tested. Determined by design and verified by qualification.

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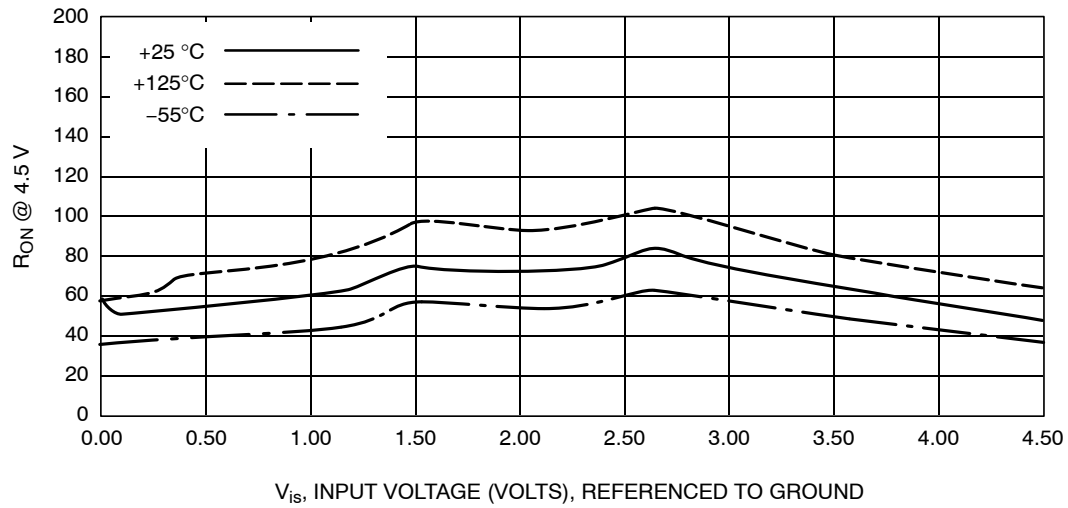


Figure 3. Typical On Resistance, $V_{CC} = 4.5$ V

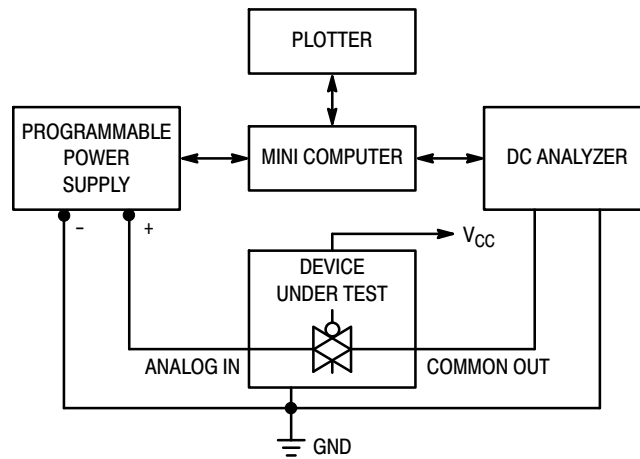


Figure 4. On Resistance Test Set-Up

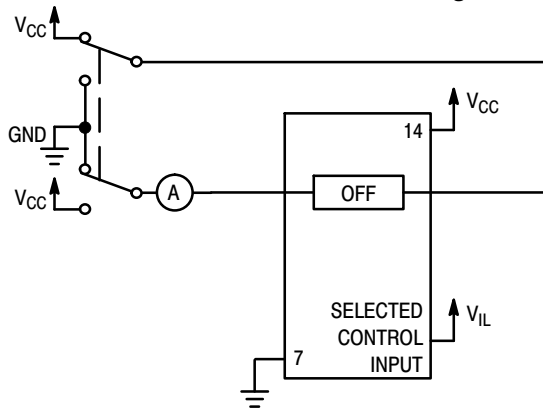


Figure 5. Maximum Off Channel Leakage Current, Any One Channel, Test Set-Up

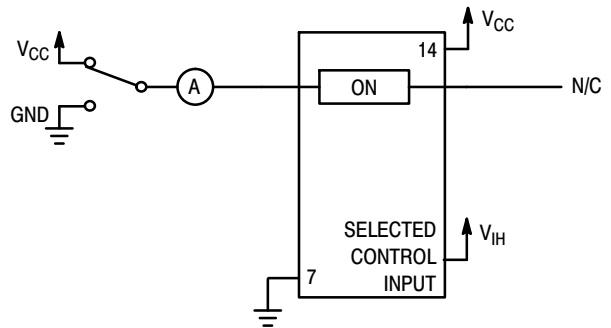
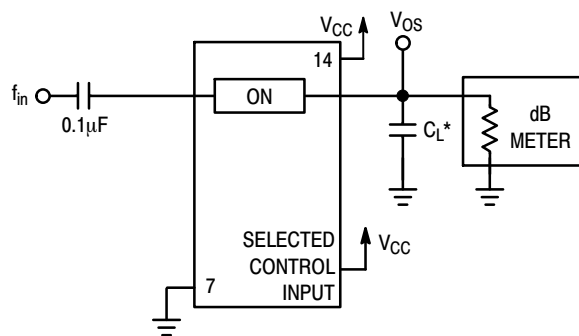


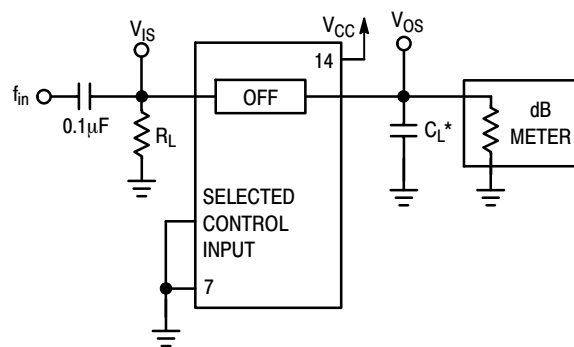
Figure 6. Maximum On Channel Leakage Current, Test Set-Up

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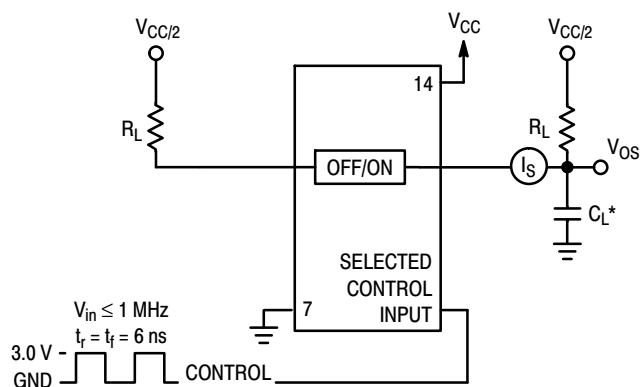
*Includes all probe and jig capacitance.

Figure 7. Maximum On-Channel Bandwidth Test Set-Up



*Includes all probe and jig capacitance.

Figure 8. Off-Channel Feedthrough Isolation, Test Set-Up



*Includes all probe and jig capacitance.

Figure 9. Feedthrough Noise, ON/OFF Control to Analog Out, Test Set-Up

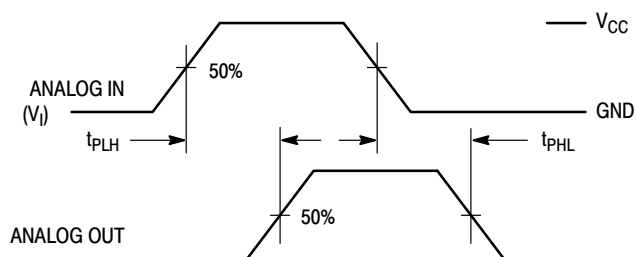
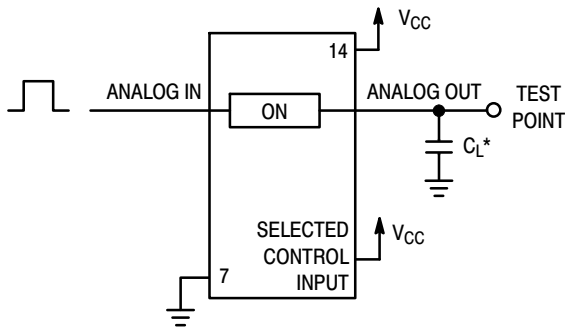


Figure 10. Propagation Delays, Analog In to Analog Out

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*Includes all probe and jig capacitance.

Figure 11. Propagation Delay Test Set-Up

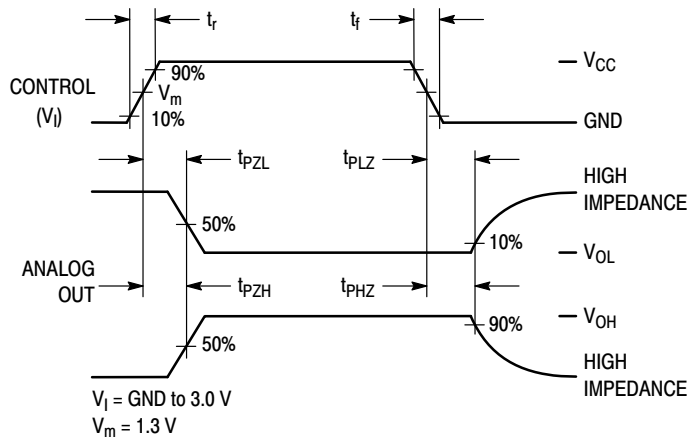
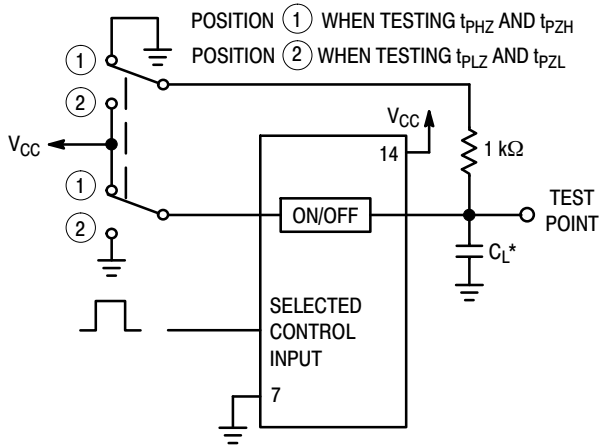
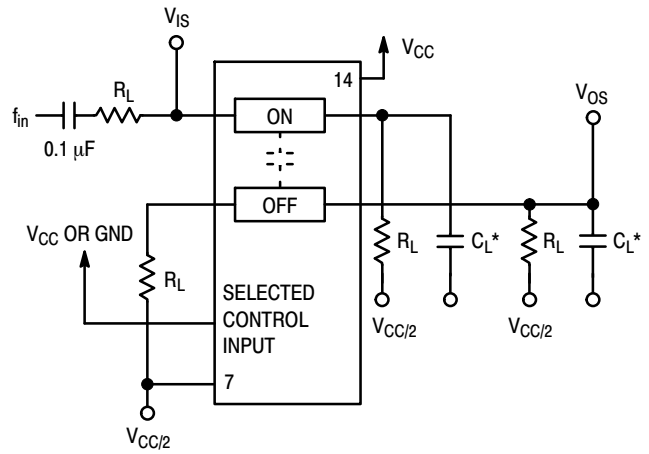


Figure 12. Propagation Delay, ON/OFF Control to Analog Out



*Includes all probe and jig capacitance.

Figure 13. Propagation Delay Test Set-Up



*Includes all probe and jig capacitance.

Figure 14. Crosstalk Between Any Two Switches, Test Set-Up

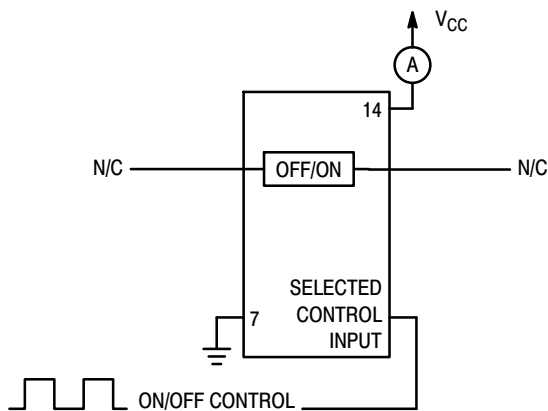
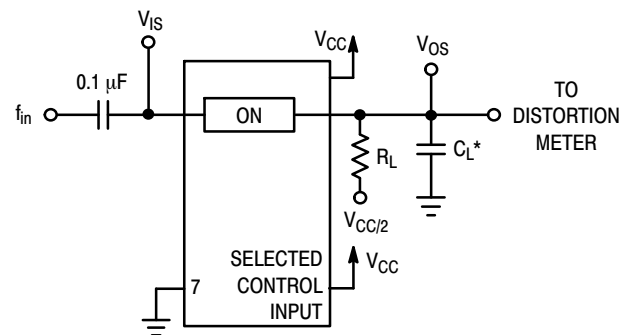


Figure 15. Power Dissipation Capacitance Test Set-Up



*Includes all probe and jig capacitance.

Figure 16. Total Harmonic Distortion, Test Set-Up

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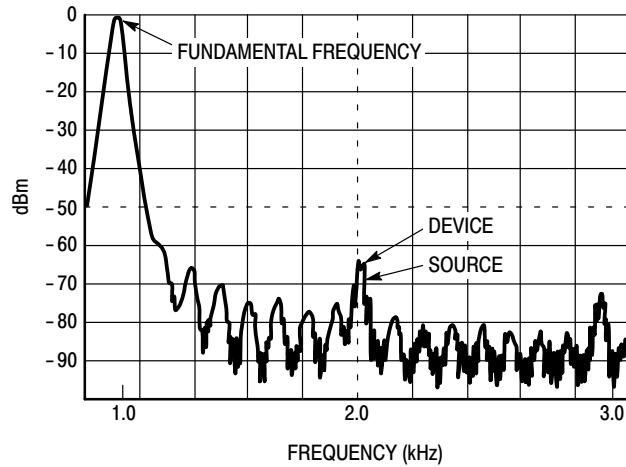


Figure 17. Plot, Harmonic Distortion

APPLICATION INFORMATION

Unused analog inputs/outputs may be left floating (not connected). However, it is advisable to tie unused analog inputs and outputs to V_{CC} or GND through a low value resistor. This minimizes crosstalk and feedthrough noise that may be picked-up by the unused I/O pins.

The maximum analog voltage swings are determined by the supply voltages V_{CC} and GND. The positive peak analog voltage should not exceed V_{CC} . Similarly, the negative peak analog voltage should not go below GND. In the example below, the difference between V_{CC} and GND is twelve volts. Therefore, using the configuration in Figure 16, a maximum

analog signal of twelve volts peak-to-peak can be controlled.

When voltage transients above V_{CC} and/or below GND are anticipated on the analog channels, external diodes (D_x) are recommended as shown in Figure 17. These diodes should be small signal, fast turn-on types able to absorb the maximum anticipated current surges during clipping. An alternate method would be to replace the D_x diodes with MOSORB® (MOSORB is an acronym for high current surge protectors). MOSORBs are fast turn-on devices ideally suited for precise DC protection with no inherent wear out mechanism.

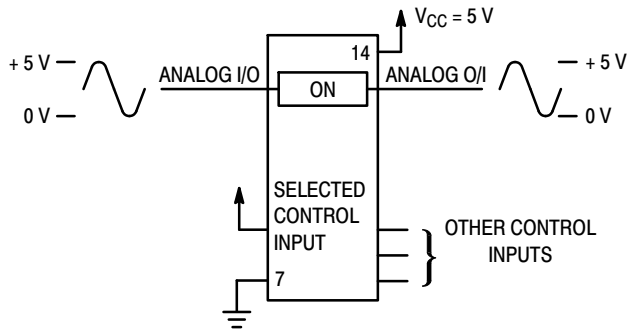


Figure 18. 5 V Application

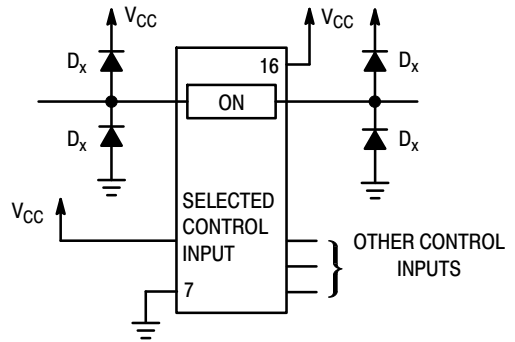
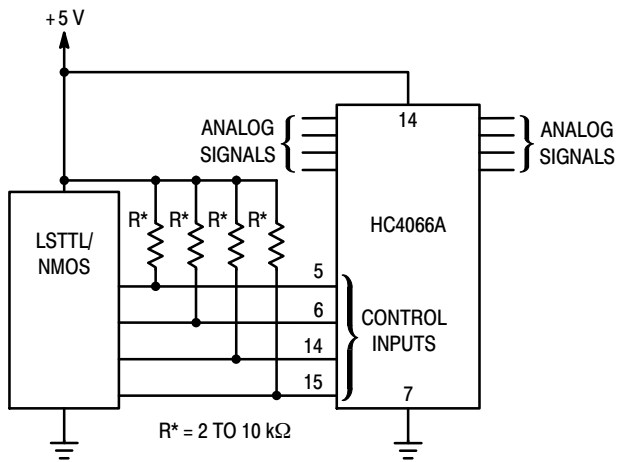
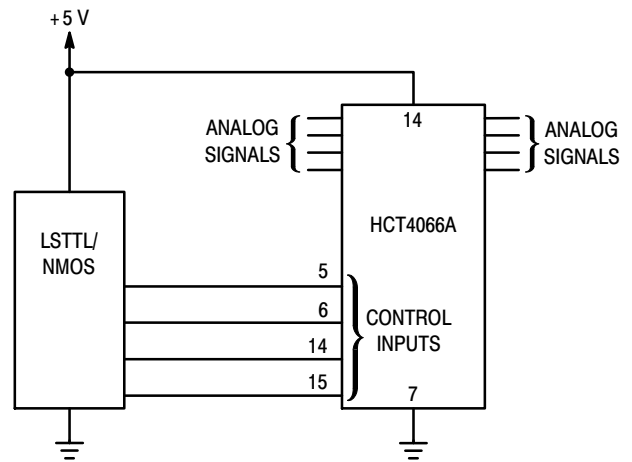


Figure 19. Transient Suppressor Application

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a. Using Pull-Up Resistors with HC Device



b. Using HCT Buffer

Figure 20. LSTTL/NMOS to HCTMOS Interface

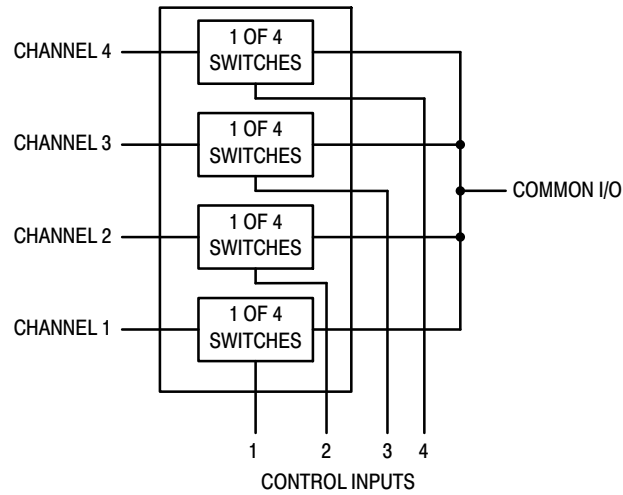


Figure 21. 4-Input Multiplexer

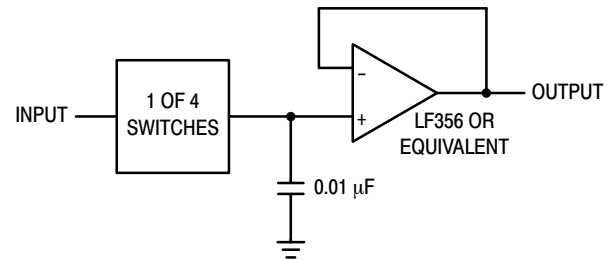
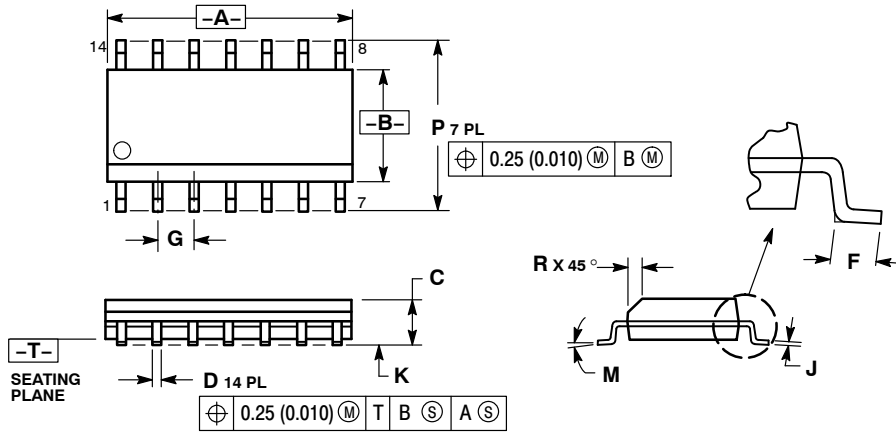


Figure 22. Sample/Hold Amplifier

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PACKAGE DIMENSIONS

SOIC-14
CASE 751A-03
ISSUE J

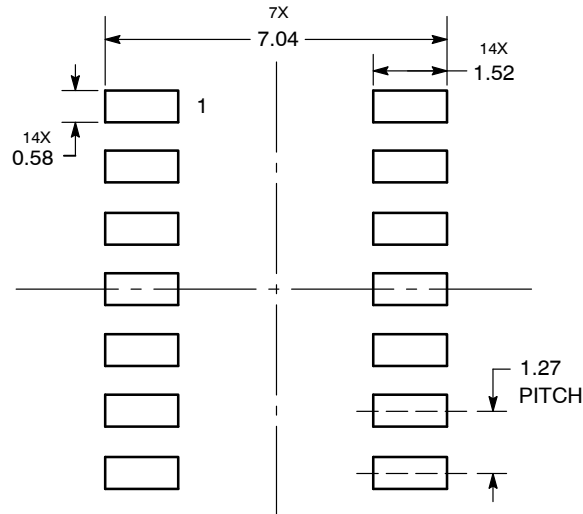


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	8.55	8.75	0.337	0.344
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27 BSC		0.050 BSC	
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
P	5.80	6.20	0.228	0.244
R	0.25	0.50	0.010	0.019

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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